

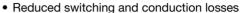
# N-Channel 600V (D-S) Super Junction Power MOSFET

PRODUCT SUMMARY			
V <sub>DS</sub> (V) at T <sub>J</sub> max.	600		
R <sub>DS(on)</sub> at 25 °C (Ω)	V <sub>GS</sub> = 10 V	0.150	

## **FEATURES**



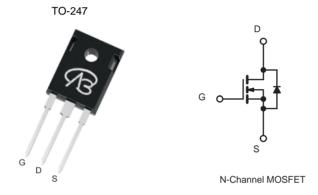




- Ultra low gate charge (Q<sub>q</sub>)
- Avalanche energy rated (UIS)

## **APPLICATIONS**

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
  - High-intensity discharge (HID)
  - Fluorescent ballast lighting



ABSOLUTE MAXIMUM RATINGS (TC:	= 25 °C, unl	ess otherwis	se noted)		
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			$V_{DS}$	600	V
Gate-Source Voltage			$V_{GS}$	± 30	7
Continuous Drain Current (T <sub>.I</sub> = 150 °C)	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C		20	
Continuous Drain Current (1) = 130°C)	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C		12	А
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	60	
Linear Derating Factor				1.67	W/°C
Single Pulse Avalanche Energy b			E <sub>AS</sub>	1000	mJ
Maximum Power Dissipation			$P_{D}$	160	W
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C
Drain-Source Voltage Slope T <sub>J</sub> = 125 °C			dV/dt	50	V/ns
Reverse Diode dV/dt <sup>d</sup>				15	V/IIS
Soldering Recommendations (Peak Temperature) c for 10 s			260	°C	

- a. Repetitive rating; pulse width limited by maximum junction temperature.
- b.  $V_{DD}$  = 100 V, starting  $T_J$  = 25 °C, L = 30mH,  $R_g$  = 25  $\Omega$ ,  $I_{AS}$  =13A. c. 1.6 mm from case. d.  $I_{SD} \le I_D$ , dl/dt = 100 A/ $\mu$ s, starting  $T_J$  = 25 °C.



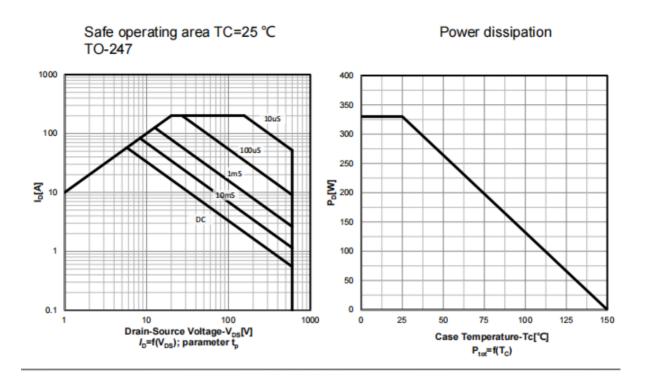
THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62	°C/W	
Maximum Junction-to-Case (Drain)	$R_{thJC}$	-	0.38	C/VV	

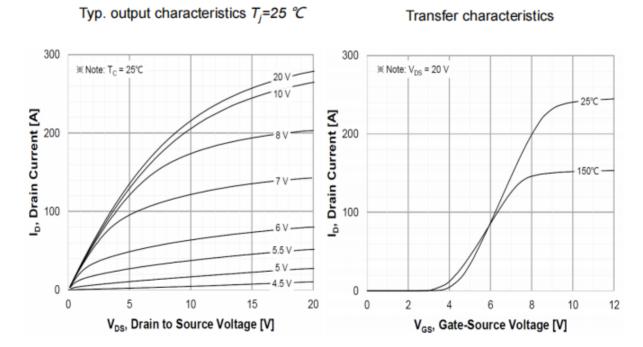
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static					•	•	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> :	= 0 V, I <sub>D</sub> = 1 mA	600	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I <sub>D</sub> = 1 mA	-	0.70	-	V/°C
Gate-Source Threshold Voltage (N)	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.5	-	4.5	V
• ( )		V <sub>GS</sub> = ± 20 V		-	-	± 100	nA
Gate-Source Leakage	$I_{GSS}$		$V_{GS} = \pm 30 \text{ V}$		-	± 1	μΑ
		V <sub>DS</sub> =	= 600V, V <sub>GS</sub> = 0 V	-	-	1	
Zero Gate Voltage Drain Current	$I_{DSS}$		/, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	100	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> =7A	-	0.150	-	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub>	= 30 V, I <sub>D</sub> = 7A	-	5.6	-	S
Dynamic							1
Input Capacitance	C <sub>iss</sub>		V <sub>GS</sub> = 0 V,	-	2300	-	
Output Capacitance	C <sub>oss</sub>		$V_{DS} = 100 V$ ,	-	330	-	
Reverse Transfer Capacitance	C <sub>rss</sub>		f = 1 MHz		4	-	pF
Effective Output Capacitance, Energy Related <sup>a</sup>	C <sub>o(er)</sub>	V <sub>DS</sub> = 0 V to 520 V, V <sub>GS</sub> = 0 V		-	63	-	
Effective Output Capacitance, Time Related <sup>b</sup>	C <sub>o(tr)</sub>			-	213	-	
Total Gate Charge	Qg			-	62	-	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$V_{GS} = 10 \text{ V}$ $I_D = 20 \text{ A}, V_{DS} = 520 \text{ V}$		39	-	nC
Gate-Drain Charge	Q <sub>gd</sub>				47	-	
Turn-On Delay Time	t <sub>d(on)</sub>			1	18	25	
Rise Time	t <sub>r</sub>	$V_{DD} = 520 \text{ V}, I_{D} = 20\text{A},$ $V_{GS} = 10 \text{ V}, R_{g} = 9.1 \Omega$		1	24	55	ns
Turn-Off Delay Time	t <sub>d(off)</sub>			-	80	-	
Fall Time	t <sub>f</sub>			1	12	-	
Gate Input Resistance	$R_g$	f = 1 MHz, open drain		1	0.8	-	Ω
<b>Drain-Source Body Diode Characteristic</b>	s						
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	20	^
Pulsed Diode Forward Current	I <sub>SM</sub>			1	-	60	A
Diode Forward Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 8 A, V <sub>GS</sub> = 0 V		-	-	1.5	V
Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = I <sub>S</sub> = 8 A, dI/dt = 100 A/μs, V <sub>R</sub> = 400 V		-	80	-	ns
Reverse Recovery Charge	Q <sub>rr</sub>			-	5.8	-	μC
Reverse Recovery Current	I <sub>RRM</sub>			_	45	_	A

## Notes

- a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ . b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .





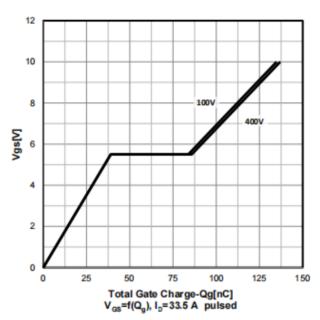




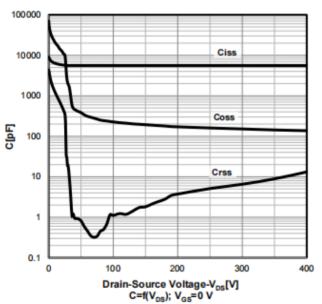
Typ. drain-source on-state resistance

80
70
60
60
40
30
20
0 15 30 45 60 75 90
Drain-Source Current-I<sub>D</sub>[A]
R<sub>DS</sub>(on)=f(I<sub>D</sub>); parameter:V<sub>GS</sub>

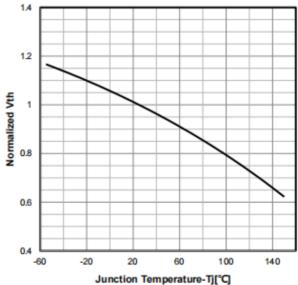
Typ. gate charge characteristics



Typ. capacitances



## Normalized $V_{\text{GS(th)}}$ characteristics

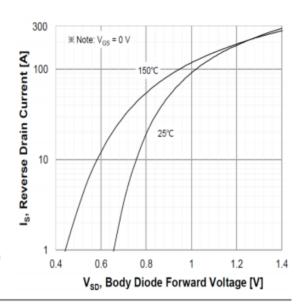




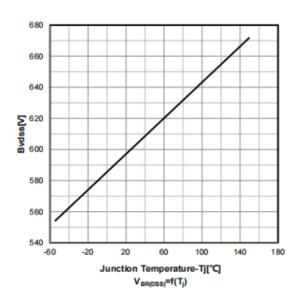
## On-resistance vs temperature

# 120 100 80 40 40 40 20 0 -60 -20 20 60 100 140 180 Junction Temperature-TJ[°C] R<sub>DS</sub>(on)=f(T<sub>J</sub>); I<sub>D</sub>=33.5 A; V<sub>GS</sub>=10 V

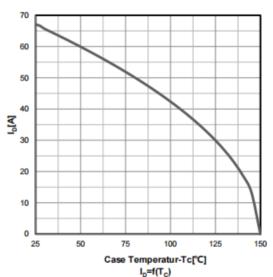
## Forward characteristics of reverse diode



## Drain-source breakdown voltage



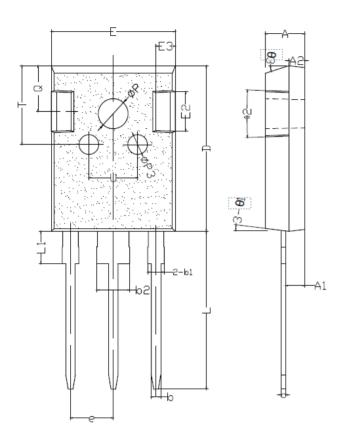
## Drain current vs temperature

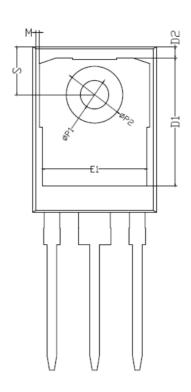


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## **TO-247 PACKAGE OUTLINE DIMENSIONS**







SYMBOL -	mm				
	MIN	NOM	MAX		
*A	4.90	5.00	5.10		
*A1	2.31	2.41	2.51		
A2	1.90	2.00	2.10		
*b	1.15	1.20	1.25		
*b1	1.95	2.10	2.25		
*b2	2.95	3.10	3.25		
*c	0.55	0.60	0.65		
*D	20.90	21.00	21.10		
D1	16.35	16.55	16.75		
D2	1.05	1.20	1.35		



*E	15.70	15.80	15.90
E1	13.10	13.25	13.40
E2	4.85	4.95	5.10
E3	2.40	2.50	2.60
*e	5.40	5.44	5.48
*L	19.80	19.98	20.15
*L1	-	-	4.30
*ФР	3.40	3.50	3.60
*ФР1	6.90	7.10	7.30
ФР2	2.40	2.50	2.60
ФР3	2.40	2.50	2.60
Q	5.60	5.80	6.00
*S	6.05	6.15	6.25
Т	9.80	10.00	10.20
U	6.00	6.20	6.40
θ1	5°	7°	9°
θ2	1°	3°	5°
θ3	13°	15°	17°

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